# MOSFET - N-Channel Shielded Gate POWERTRENCH® 80 V, 64 A, 6.8 mΩ

# FDMC007N08LCDC

# **General Description**

This N-Channel MV MOSFET is produced using ON Semiconductor's advanced PowerTrench process that incorporates Shielded Gate technology. This process has been optimized to minimize on-state resistance and yet maintain superior switching performance with best in class soft body diode.

## **Features**

- Shielded Gate MOSFET Technology
- Max  $R_{DS(on)} = 6.8 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 22 \text{ A}$
- Max  $R_{DS(on)} = 11.1 \text{ m}\Omega$  at  $V_{GS} = 4.5 \text{ V}$ ,  $I_D = 18 \text{ A}$
- 5 V Drive Capable
- 50% Lower Q<sub>rr</sub> than Other MOSFET Suppliers
- Lowers Switching Noise/EMI
- MSL1 Robust Package Design
- 100% UIL Tested
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

# **Applications**

- Primary DC-DC MOSFET
- Synchronous Rectifier in DC-DC and AC-DC
- Motor Drive
- Solar

# MAXIMUM RATINGS (T<sub>A</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain to Source Voltage	80	V
$V_{GS}$	Gate to Source Voltage	±20	V
I <sub>D</sub>		64 41 15 339	A
E <sub>AS</sub>	Single Pulse Avalanche Energy (Note 3)	150	mJ
P <sub>D</sub>	Power Dissipation: T <sub>C</sub> = 25°C T <sub>A</sub> = 25°C (Note 1a)	57 3	W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range	–55 to +150	°C

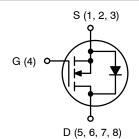
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



# ON Semiconductor®

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V <sub>DS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
80 V	6.8 mΩ @ 10 V	22 A
	11.1 mΩ @ 4.5 V	



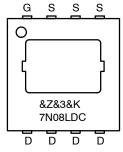
**N-CHANNEL MOSFET** 





Dual Cool™ 33 (PQFN8) CASE 483AY

# **MARKING DIAGRAM**



&Z = Assembly Plant Code &3 = Numeric Date Code

&K = Lot Code

7N08LDC = Specific Device Code

# **ORDERING INFORMATION**

See detailed ordering and shipping information on page 6 of this data sheet.

# THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case	2.2	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	42	

# **ELECTRICAL CHARACTERISTICS** (T<sub>.I</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHARA	ACTERISTICS		•	•	•	
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0 V	80			V
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, referenced to 25°C		67		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 64 V, V <sub>GS</sub> = 0 V			1	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA
ON CHARA	CTERISTICS					
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 130 μA	1.0	1.5	2.5	V
$\Delta V_{GS(th)} / \Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 130 μA, referenced to 25°C		-5.2		mV/°C
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 22 A		5.1	6.8	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 18 A		7.3	11.1	
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 22 A, T <sub>J</sub> = 125°C		9.5	12.5	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 22 A		80		S
DYNAMIC C	HARACTERISTICS		•	•	•	
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V, f = 1 MHz		2195	3070	pF
C <sub>oss</sub>	Output Capacitance	1		521	730	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1		25	40	pF
R <sub>g</sub>	Gate Resistance		0.1	0.5	0.9	Ω
SWITCHING	CHARACTERISTICS		•	•	•	
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 40 \text{ V}, I_D = 22 \text{ A}, V_{GS} = 10 \text{ V},$		11	21	ns
t <sub>r</sub>	Rise Time	$R_{GEN} = 6 \Omega$		3	10	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	1		36	58	ns
t <sub>f</sub>	Fall Time	1		4	10	ns
Qg	Total Gate Charge	$V_{GS} = 0$ V to 10 V, $V_{DD} = 40$ V, $I_D = 22$ A		31	44	nC
		$V_{GS}$ = 0 V to 4.5 V, $V_{DD}$ = 40 V, $I_D$ = 22 A		15	21	nC
Q <sub>gs</sub>	Gate to Source Charge	V <sub>DD</sub> = 40 V, I <sub>D</sub> = 22 A		5		nC
$Q_{gd}$	Gate to Drain "Miller" Charge	V <sub>DD</sub> = 40 V, I <sub>D</sub> = 22 A		4		nC
Q <sub>oss</sub>	Output Charge	V <sub>DD</sub> = 40 V, V <sub>GS</sub> = 0 V		29		nC
Q <sub>sync</sub>	Total Gate Charge Sync	V <sub>DS</sub> = 0 V, I <sub>D</sub> = 22 A		28		nC
DRAIN-SOU	IRCE DIODE CHARACTERISTICS					
V <sub>SD</sub>	Source to Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 2.5 A (Note 2)		0.7	1.2	V
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 22 A (Note 2)		0.8	1.3	
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 11 A, di/dt = 300 A/μs		18	32	ns
Q <sub>rr</sub>	Reverse Recovery Charge	1		24	38	nC
	1	1				

# ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS						
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 11 A, di/dt = 1000 A/μs		15	26	ns
Q <sub>rr</sub>	Reverse Recovery Charge			60	96	nC

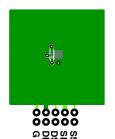
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### THERMAL CHARACTERISTICS

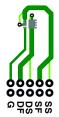
Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case (Top Source)	6.0	°C/W
$R_{ heta JC}$	Thermal Resistance, Junction to Case (Bottom Source)	2.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	42	°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient (Note 1b)	105	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1c)	29	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1d)	40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1e)	19	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1f)	23	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1g)	30	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1h)	79	°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient (Note 1i)	17	°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient (Note 1j)	26	°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient (Note 1k)	12	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1I)	16	°C/W

# NOTES:

R<sub>θ,JA</sub> is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R<sub>θ,JC</sub> is guaranteed by design while R<sub>θ,CA</sub> is determined by the user's board design.



a) 42°C/W when mounted on a 1 in² pad of 2 oz copper.



 b) 105°C/W when mounted on a minimum pad of 2 oz copper.

- c. Still air,  $20.9 \times 10.4 \times 12.7$  mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- d. Still air,  $20.9 \times 10.4 \times 12.7$  mm Aluminum Heat Sink, minimum pad of 2 oz copper
- e. Still air,  $45.2 \times 41.4 \times 11.7$  mm Aavid Thermalloy Part # 10–L41B–11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- f. Still air, 45.2 × 41.4 × 11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- g. 200FPM Airflow, No Heat Sink,1 in2 pad of 2 oz copper
- h. 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper
- i. 200FPM Airflow,  $20.9 \times 10.4 \times 12.7$  mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- j. 200FPM Airflow,  $20.9 \times 10.4 \times 12.7$  mm Aluminum Heat Sink, minimum pad of 2 oz copper
- k. 200FPM Airflow,  $45.2 \times 41.4 \times 11.7$  mm Aavid Thermalloy Part # 10–L41B–11 Heat Sink, 1 in 2 pad of 2 oz copper a sink in 2 pad of 2 oz copper between the contract of the
- $I. \ \ 200 FPM \ Airflow, \ 45.2 \times 41.4 \times 11.7 \ mm \ Aavid \ Thermalloy \ Part \ \# \ 10-L41B-11 \ Heat \ Sink, \ minimum \ pad \ of \ 2 \ oz \ copper \ Model \ Airflow \ Air$
- 2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0%.
- 3.  $E_{AS}$  of 150 mJ is based on starting  $T_J = 25^{\circ}C$ ; L = 3 mH,  $I_{AS} = 10$  A,  $V_{DD} = 80$  V,  $V_{GS} = 10$  V. 100% test at L = 0.1 mH,  $I_{AS} = 32$  A.
- 4. Pulsed Id please refer to Figure 11 SOA graph for more details.
- 5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

# **TYPICAL CHARACTERISTICS**

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ 

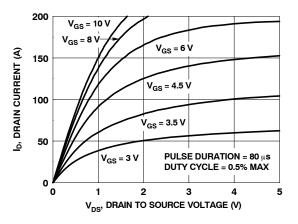


Figure 1. On Region Characteristics

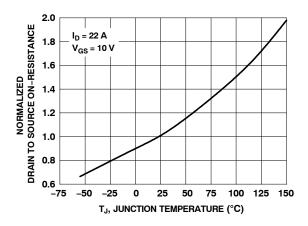


Figure 3. Normalized On-Resistance vs. Junction Temperature

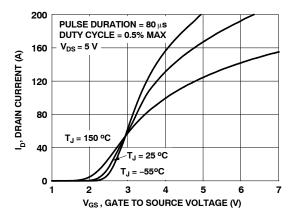


Figure 5. Transfer Characteristics

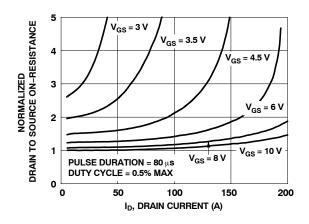


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

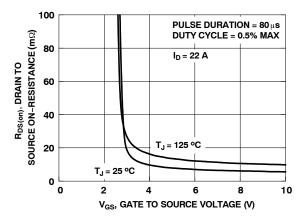


Figure 4. On-Resistance vs. Gate to Source Voltage

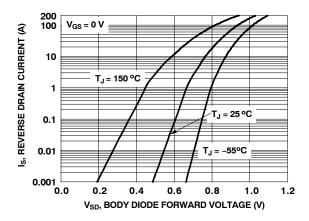


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

# **TYPICAL CHARACTERISTICS**

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ 

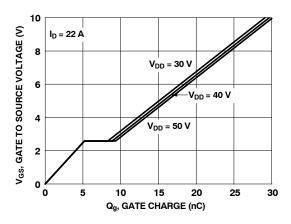


Figure 7. Gate Charge Characteristics

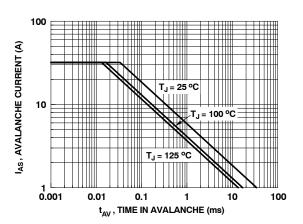


Figure 9. Unclamped Inductive Switching Capability

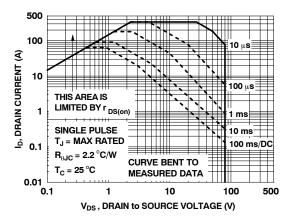


Figure 11. Forward Bias Safe Operating Area

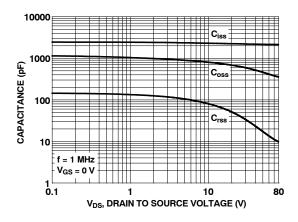


Figure 8. Capacitance vs. Drain to Source Voltage

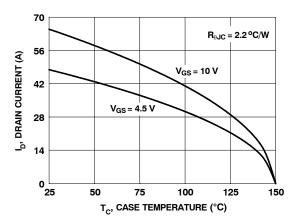


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

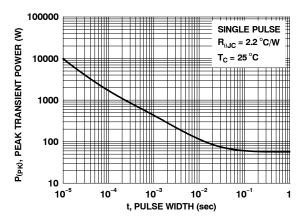


Figure 12. Single Pulse Maximum Power Dissipation

# **TYPICAL CHARACTERISTICS**

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ 

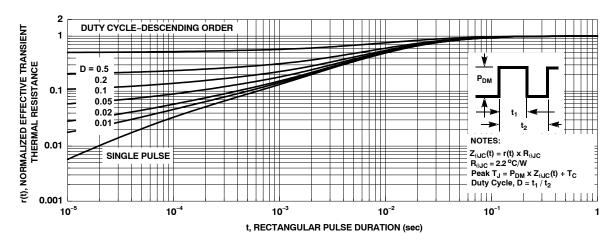


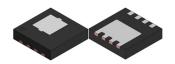
Figure 13. Junction-to-Case Transient Thermal Response Curve

# **ORDERING INFORMATION**

Device	Marking	Package	Reel Size	Tape Width	Quantity
FDMC007N08LCDC	7N08LDC	Dual Cool™ 33 (PQFN8) (Pb-Free / Halogen Free)	13″	12 mm	3000 Units

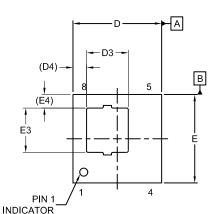
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# PQFN8 3.3X3.3, 0.65P CASE 483AY **ISSUE A**

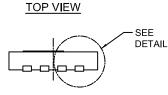
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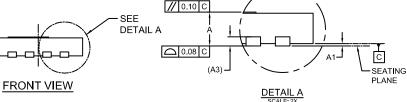


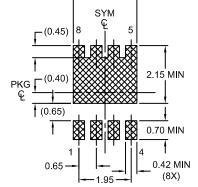
#### NOTES:

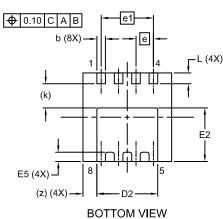
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- 4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- 5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

DIM	IV	IILLIMET	ERS			
Diivi	MIN.	NOM.	MAX.			
Α	0.70	0.75	0.80			
A1	0.00	-	0.05			
А3	(	.20 REF				
b	0.27	0.32	0.37			
D	3.20	3.30	3.40			
D2	2.17	2.27	2.37			
D3	1.45	1.55	1.65			
D4	(	).51 REF	•			
E	3.20	3.30	3.40			
E2	1.85	1.95	2.05			
E3	1.55	1.65	1.75			
E4	(	).51 REF	•			
E5	0.24	0.34	0.44			
е	(	0.65 BSC	;			
e1	1	1.95 BSC	;			
k	(	).90 REF				
L	0.30	0.40	0.50			
z	0.52 REF					
2.37	- 2.37 MIN					









# LAND PATTERN RECOMMENDATION

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

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DESCRIPTION:	PQFN8 3.3X3.3, 0.65P		PAGE 1 OF 1

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